

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/701,183	AKKERMAN ET AL.	
Examiner	Art Unit	
Thanh T Nauven	2813	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
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